

<b>Notice of References Cited</b>	Application/Control No. 09/559,691	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Emmanuel Bayard	Art Unit 2631	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,122,118	09-2000	Sato et al.	360/46
	B	US-5,214,672	05-1993	Eyuboglu et al.	375/254
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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